

United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/616,896	07/09/2003	Stephen R. Quake	020859-001310US	1651
20350	7590 10/18/2004		EXAM	INER
	AND TOWNSEND AN	LEE, PA	LEE, PATRICK J	
TWO EMBAR EIGHTH FLO	RCADERO CENTER OR		ART UNIT	PAPER NUMBER
SAN FRANCISCO, CA 94111-3834			2878	

DATE MAILED: 10/18/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

			770			
		Application No.	Applicant(s)			
Office Action Summary		10/616,896	QUAKE ET AL.			
		Examiner	Art Unit			
		Patrick J. Lee	2878			
Period fo	The MAILING DATE of this communication app or Reply	pears on the cover sheet with the c	orrespondence address			
THE - Exte after - If the - If NO - Failt Any	ORTENED STATUTORY PERIOD FOR REPLY MAILING DATE OF THIS COMMUNICATION. nsions of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. e period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period vare to reply within the set or extended period for reply will, by statute reply received by the Office later than three months after the mailing ed patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be tir y within the statutory minimum of thirty (30) day vill apply and will expire SIX (6) MONTHS from , cause the application to become ABANDONE	nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).			
Status						
1)⊠	Responsive to communication(s) filed on 09 Ju	<u>uly 2003</u> .				
2a) <u></u>	This action is FINAL. 2b) This	·				
3)	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.					
Disposit	ion of Claims					
5) 6) 7)	4)					
Applicat	ion Papers					
10)	The specification is objected to by the Examine The drawing(s) filed on is/are: a) acc Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct The oath or declaration is objected to by the Ex	epted or b) objected to by the drawing(s) be held in abeyance. Se tion is required if the drawing(s) is ob	e 37 CFR 1.85(a). ejected to. See 37 CFR 1.121(d).			
Priority	under 35 U.S.C. § 119					
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 						
			·			
Attachmer	nt(s) ce of References Cited (PTO-892)	4) 🔲 Interview Summary	(PT∩.413)			
2) Notice	ce of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail D	ate			
	mation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) er No(s)/Mail Date	5) Notice of Informal F 6) Other:	Patent Application (PTO-152)			

Art Unit: 2878

DETAILED ACTION

Election/Restrictions

- 1. Restriction to one of the following inventions is required under 35 U.S.C. 121:
 - Claims 1-30, drawn to a method/system of measuring characteristics through an intensity change, classified in class 356, subclass 301.
 - II. Claims 31-36, drawn to a method of aligning the beam emitted by a probe, classified in class 356, subclass 73.
 - III. Claims 37-45, drawn to a system for a microscope system with shock absorption, classified in class 359, subclass 368.
 - IV. Claims 46-54, drawn to a scanning system utilizing a noise free devices for the sample, classified in class 250, subclass 234.
 - V. Claims 55-87, drawn to a system/method for microscopy utilizing a nanotube tip probe, classified in class 977, subclass DIG 1.
 - VI. Claims 88-111, drawn to a system/method for aligning the beam utilizing a field of view technique, classified in class 600, subclass 473.
 - VII. Claims 112-117, drawn to a scanning microscope, classified in class 250, subclass 235.

The inventions are distinct, each from the other because of the following reasons:

2. Inventions I, II, III, IV, V, VI, and VII are related as subcombinations disclosed as usable together in a single combination. The subcombinations are distinct from each other if they are shown to be separately usable. In the instant case, invention II has separate utility such as for a photolithography device. See MPEP § 806.05(d).

Art Unit: 2878

- 3. Because these inventions are distinct for the reasons given above and have acquired a separate status in the art as shown by their different classification, restriction for examination purposes as indicated is proper.
- 4. A telephone call was not made to applicant's representative due to the complex nature of the restriction.

Applicant is advised that the reply to this requirement to be complete must include an election of the invention to be examined even though the requirement be traversed (37 CFR 1.143).

5. Applicant is reminded that upon the cancellation of claims to a non-elected invention, the inventorship must be amended in compliance with 37 CFR 1.48(b) if one or more of the currently named inventors is no longer an inventor of at least one claim remaining in the application. Any amendment of inventorship must be accompanied by a request under 37 CFR 1.48(b) and by the fee required under 37 CFR 1.17(i).

Conclusion

6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Patrick J. Lee whose telephone number is (571) 272-2440. The examiner can normally be reached on Monday through Friday, 8:00 am to 5:30 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David P. Porta can be reached on (571) 272-2444. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Application/Control Number: 10/616,896

Art Unit: 2878

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Patrick J. Lee Examiner Art Unit 2878 Page 4

PJL September 30th, 2004

Stephone B. Allen Primary Examiner

2 hope 3 all